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# SINGLE-SUPPLY, AUTO-ZERO SENSOR AMPLIFIER WITH PROGRAMMABLE GAIN AND OFFSET

Check for Samples: PGA308-DIE

## **FEATURES**

- Digital Calibration for Bridge Sensors
- Offset Select: Coarse and Fine
- Gain Select: Coarse and Fine
- Bridge Fault Monitor
- Input Mux for Lead Swap
- Over/Under Scale Limits
- D<sub>OUT</sub>/ V<sub>OUT</sub> Clamp Function
- Seven Banks OTP Memory

- One-Wire Digital UART Interface
- Operating Voltage: 2.7 V to 5.5 V

# **APPLICATIONS**

- Bridge Sensors
- Remote Transmitters
- Strain, Load, Weigh Scales
- Automotive Sensors

## DESCRIPTION

The PGA308 is a programmable analog sensor signal conditioner. The analog signal path amplifies the sensor signal and provides digital calibration for offset and gain. Calibration is done via the 1W pin, a digital One-Wire, UART-compatible interface. For three-terminal sensor modules, 1W may be connected to  $V_{OUT}$  and the assembly programmed through the  $V_{OUT}$  pin. Gain and offset calibration parameters are stored onboard in seven banks of one-time programmable (OTP) memory. The power-on reset (POR) OTP bank may be programmed a total of four times.

The all-analog signal path contains a  $2\times2$  input multiplexer (mux) to allow electronic sensor lead swapping, a coarse offset adjust, an auto-zero programmable gain instrumentation amplifier (PGA), a fine gain adjust, a fine offset adjust, and a programmable gain output amplifier. Fault monitor circuitry detects and signals sensor burnout, overload, and system fault conditions. Over/under-scale limits provide additional means for system level diagnostics. The dual-use  $D_{OUT}/V_{CLAMP}$  pin can be used as a programmable digital output or as a  $V_{OUT}$  overvoltage clamp.

#### ORDERING INFORMATION(1)

PRODUCT	PACKAGE DESIGNATOR	PACKAGE	ORDERABLE PART NUMBER	PACKAGE QUANTITY	
PGA308	TD	Bare die in waffle pack <sup>(2)</sup>	PGA308TDD1	100	
			PGA308TDD2	10	

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.
- (2) Processing is per the Texas Instruments commercial production baseline and is in compliance with the Texas Instruments Quality Control System in effect at the time of manufacture. Electrical screening consists of DC parametric and functional testing at room temperature only. Unless otherwise specified by Texas Instruments AC performance and performance over temperature is not warranted. Visual Inspection is performed in accordance with MIL-STD-883 Test Method 2010 Condition B at 75X minimum.



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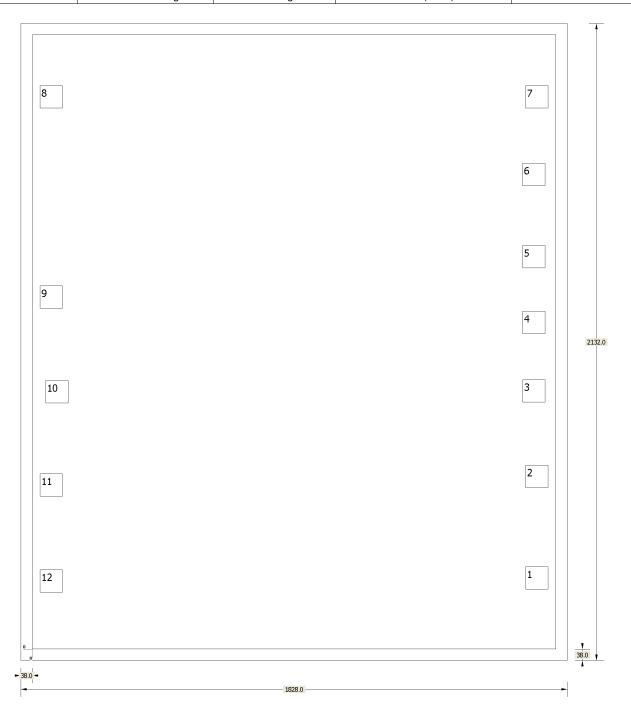


This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# **BARE DIE INFORMATION**

DIE THICKNESS	BACKSIDE FINISH	BACKSIDE POTENTIAL	BOND PAD METALLIZATION COMPOSITION	BOND PAD THICKNESS	
15 mils.	Silicon with backgrind	Floating	Al-Cu (0.5%)	598 nm	





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# Table 1. Bond Pad Coordinates in Microns<sup>(1)</sup>

DESCRIPTION	PAD NUMBER	X MIN	Y MIN	X MAX	Y MAX
D <sub>out</sub> /V <sub>clamp</sub>	1	1649.8	200.1	1725.8	276.1
1W	2	1649.8	540	1725.8	616
GND	3	1639.7	826	1715.7	902
GND	4	1639.7	1055	1715.7	1131
V <sub>S</sub>	5	1639.7	1275	1715.7	1351
V <sub>S</sub>	6	1639.7	1550	1715.7	1626
V <sub>in1</sub>	7	1649.8	1810.1	1725.8	1886.1
$V_{in2}$	8	26.2	1810.1	102.2	1886.1
$V_{sj}$	9	26.2	1140	102.2	1216
$V_{fb}$	10	44.55	823	120.55	899
V <sub>out</sub>	11	26.2	510.85	102.2	586.85
V <sub>ref</sub>	12	26.2	189.9	102.2	265.9

<sup>(1)</sup> Substrate N/C.

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## PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
PGA308TDD1	Active	Production	null (null)   0	100   OTHER	Yes	Call TI	N/A for Pkg Type	0 to 70	
PGA308TDD1.A	Active	Production	null (null)   0	100   OTHER	Yes	Call TI	N/A for Pkg Type	0 to 70	
PGA308TDD2	Active	Production	null (null)   0	10   OTHER	Yes	Call TI	N/A for Pkg Type	0 to 70	
PGA308TDD2.A	Active	Production	null (null)   0	10   OTHER	Yes	Call TI	N/A for Pkg Type	0 to 70	

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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#### OTHER QUALIFIED VERSIONS OF PGA308-DIE:

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

# PACKAGE OPTION ADDENDUM

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Automotive : PGA308-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

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